



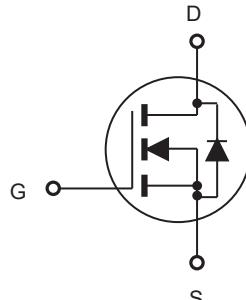
# CEP1788S/CEB1788S CEF1788S

## N-Channel Enhancement Mode Field Effect Transistor

### FEATURES

Type	$V_{DSS}@T_J \text{ max}$	$R_{DS(\text{ON})}$	$I_D$	@ $V_{GS}$
CEP1788S	900V	290mΩ	17A	10V
CEB1788S	900V	290mΩ	17A	10V
CEF1788S	900V	290mΩ	17A <sup>d</sup>	10V

- Super high dense cell design for extremely low  $R_{DS(\text{ON})}$ .
- High power and current handing capability.
- Pb-free lead plating ; RoHS compliant.
- Halogen Free.

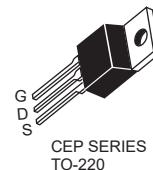


### APPLICATIONS

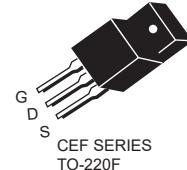
- Adapter .
- PV Inverter .
- SMPS .
- Lighting .



CEB SERIES  
TO-263(DD-PAK)



CEP SERIES  
TO-220



CEF SERIES  
TO-220F

### ABSOLUTE MAXIMUM RATINGS $T_C = 25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Limit		Units
		TO-220/263	TO-220F	
Drain-Source Voltage	$V_{DS}$	850		V
Gate-Source Voltage	$V_{GS}$	$\pm 30$		V
Drain Current-Continuous @ $T_C = 25^\circ\text{C}$ @ $T_C = 100^\circ\text{C}$	$I_D$	17 11	17 <sup>d</sup> 11 <sup>d</sup>	A
Drain Current-Pulsed <sup>a</sup>	$I_{DM}$ <sup>e</sup>	68	68 <sup>d</sup>	A
Maximum Power Dissipation @ $T_C = 25^\circ\text{C}$ - Derate above 25°C	$P_D$	208 1.66	52 0.41	W/W°C
Single Pulsed Avalanche Energy <sup>g</sup>	$E_{AS}$	112		mJ
Single Pulsed Avalanche Current <sup>g</sup>	$I_{AS}$	7		A
Operating and Store Temperature Range	$T_J, T_{stg}$	-55 to 150		°C

### Thermal Characteristics

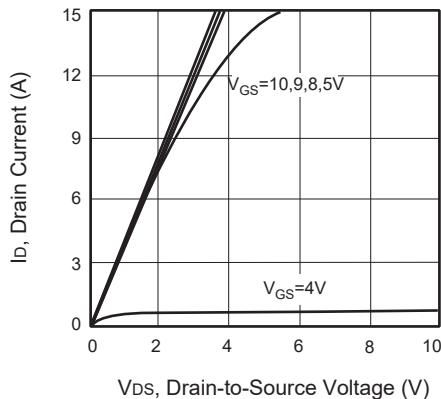
Parameter	Symbol	Limit		Units
Thermal Resistance, Junction-to-Case	$R_{JC}$	0.6	2.4	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{JA}$	62.5	65	°C/W



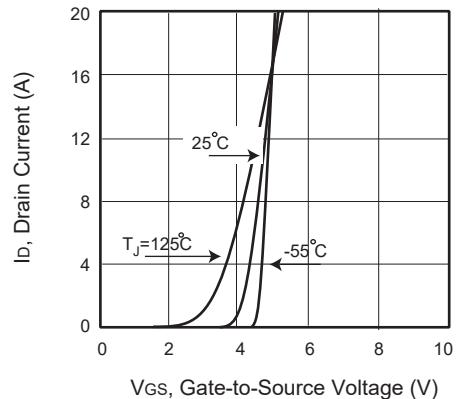
# CEP1788S/CEB1788S CEF1788S

## Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

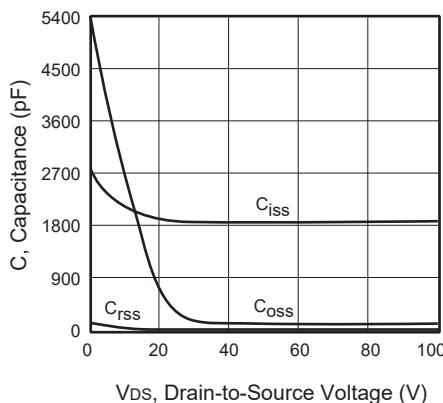
Parameter	Symbol	Test Condition	Min	Typ	Max	Units
<b>Off Characteristics</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_{\text{D}} = 250\mu\text{A}$	850			V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}} = 850\text{V}, V_{\text{GS}} = 0\text{V}$			1	$\mu\text{A}$
Gate Body Leakage Current, Forward	$I_{\text{GSSF}}$	$V_{\text{GS}} = 30\text{V}, V_{\text{DS}} = 0\text{V}$			100	nA
Gate Body Leakage Current, Reverse	$I_{\text{GSSR}}$	$V_{\text{GS}} = -30\text{V}, V_{\text{DS}} = 0\text{V}$			-100	nA
<b>On Characteristics<sup>b</sup></b>						
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}} = V_{\text{DS}}, I_{\text{D}} = 250\mu\text{A}$	2.2		3.8	V
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}} = 10\text{V}, I_{\text{D}} = 9\text{A}$		245	290	$\text{m}\Omega$
Gate Input Resistance	$R_g$	f=1MHz,open Drain		3.6		$\Omega$
<b>Dynamic Characteristics<sup>c</sup></b>						
Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}} = 100\text{V}, V_{\text{GS}} = 0\text{V}, f = 1.0 \text{ MHz}$		1820		pF
Output Capacitance	$C_{\text{oss}}$			70		pF
Reverse Transfer Capacitance	$C_{\text{rss}}$			10		pF
<b>Switching Characteristics<sup>c</sup></b>						
Turn-On Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = 400\text{V}, I_{\text{D}} = 2\text{A}, V_{\text{GS}} = 10\text{V}, R_{\text{GEN}} = 4.7\Omega$		31		ns
Turn-On Rise Time	$t_r$			6		ns
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$			90		ns
Turn-Off Fall Time	$t_f$			28		ns
Total Gate Charge	$Q_g$	$V_{\text{DS}} = 640\text{V}, I_{\text{D}} = 7\text{A}, V_{\text{GS}} = 10\text{V}$		41		nC
Gate-Source Charge	$Q_{\text{gs}}$			7		nC
Gate-Drain Charge	$Q_{\text{gd}}$			16		nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
Drain-Source Diode Forward Current	$I_s$ <sup>f</sup>	$V_{\text{GS}} = 0\text{V}, I_s = 10\text{A}$			17	A
Drain-Source Diode Forward Voltage <sup>b</sup>	$V_{\text{SD}}$				1.2	V
Reverse Recovery Time	$T_{\text{rr}}$			390		ns
Reverse Recovery Charge	$Q_{\text{rr}}$			4		uC
Peak Reverse Recovery Current	$I_{\text{rr}}$			18		A
<b>Notes :</b>						
a.Repetitive Rating : Pulse width limited by maximum junction temperature .						
b.Pulse Test : Pulse Width $\leq 300\mu\text{s}$ , Duty Cycle $\leq 2\%$ .						
c.Guaranteed by design, not subject to production testing.						
d.Limited only by maximum temperature allowed .						
e.Pulse width limited by safe operating area .						
f.Full package $I_s(\text{max}) = 8.5\text{A}$ .						
g. $L = 4.6\text{mH}, I_{\text{AS}} = 7\text{A}, V_{\text{DD}} = 50\text{V}, R_G = 25\Omega$ , Starting $T_J = 25^\circ\text{C}$ .						



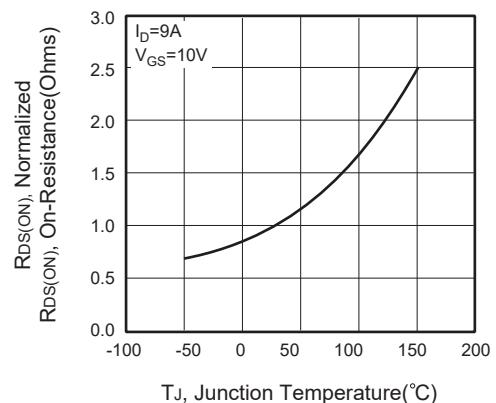
**Figure 1. Output Characteristics**



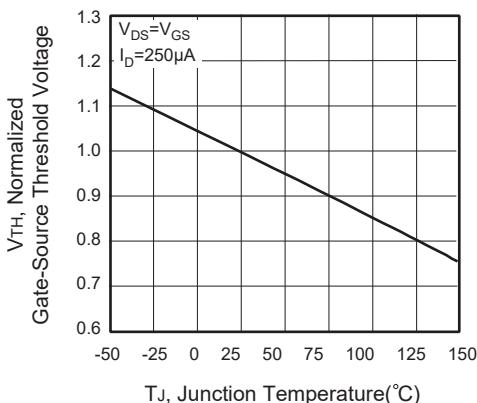
**Figure 2. Transfer Characteristics**



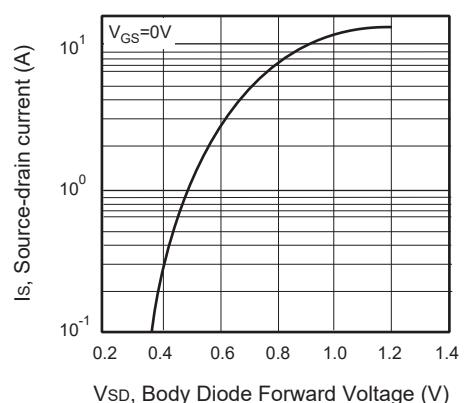
**Figure 3. Capacitance**



**Figure 4. On-Resistance Variation with Temperature**



**Figure 5. Gate Threshold Variation with Temperature**



**Figure 6. Body Diode Forward Voltage Variation with Source Current**



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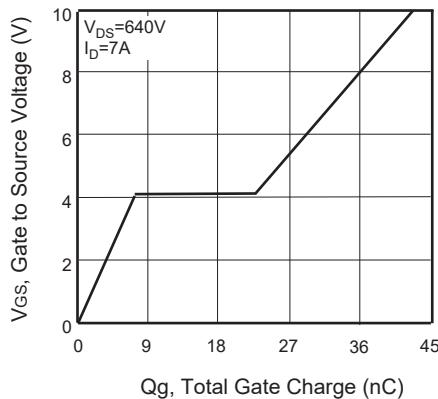


Figure 7. Gate Charge

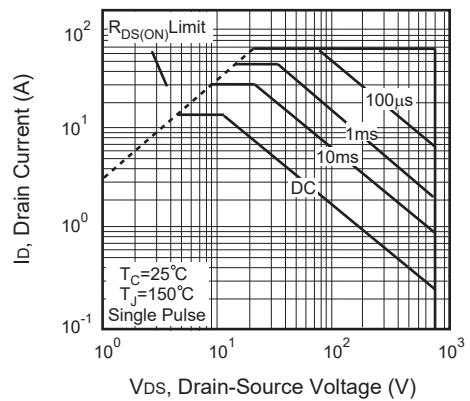


Figure 8. Maximum Safe  
Operating Area

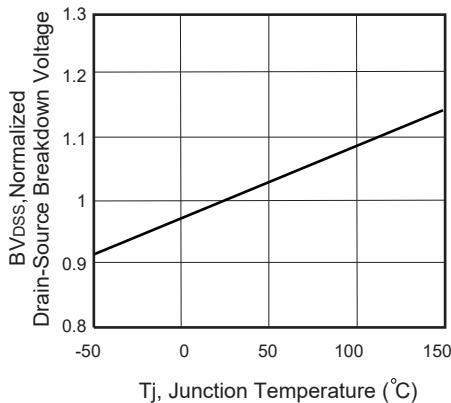


Figure 9. Breakdown Voltage Variation  
VS Temperature

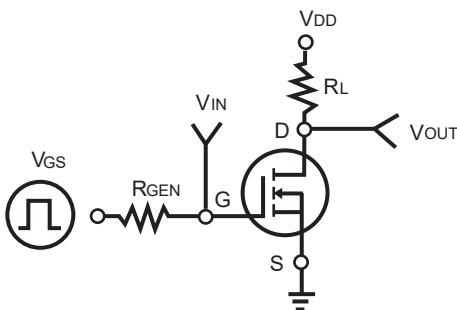


Figure 10. Switching Test Circuit

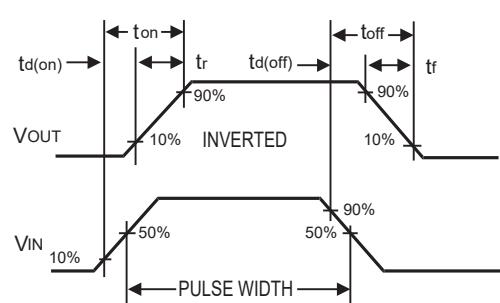
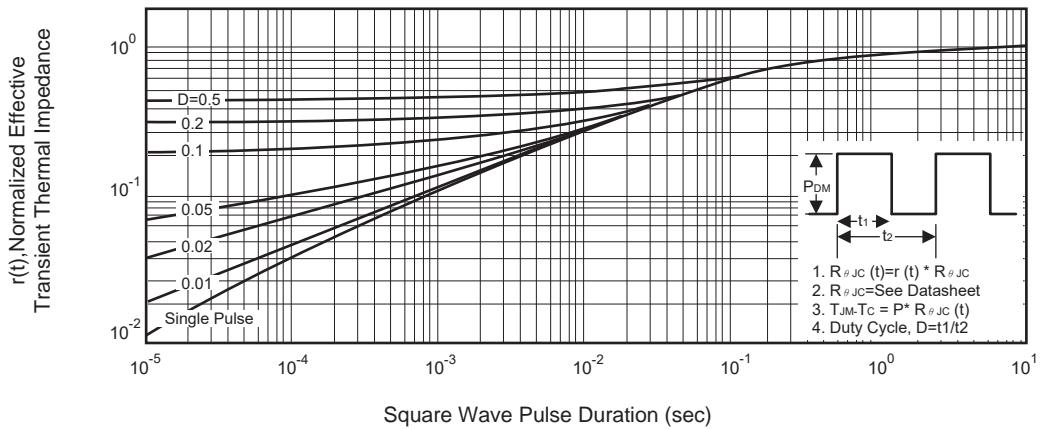


Figure 11. Switching Waveforms



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**Figure 12. Normalized Thermal Transient Impedance Curve**